Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/762,653	TANAKA ET AL.
Examiner	Art Unit
Ellen C. Tran	2134

SEARCHED				
Class	Subclass	Date	Examiner	
713	189	11/6/2007	ET	
713	166, 168	11/6/2007	ET	
726	25	11/6/2007	ET	
. 380	28	11/6/2007	ET	
380	37, 42	11/6/2007	ET	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			,,,,
USPG PUE TEXT W		11/6/2007	ET

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH	11/6/2007	ET	
NPL - IEEE XPLORE	11/6/2007	ET	
ALL CLAIMS WERE REVIEWED FOR POSSIBLE 101 REJECTION	11/6/2007	ET	
INTERFERENCE SEARCH USPG PUB CLAIM & TEXT W/CLASS	11/6/2007	ET	